

SENSITIVE SOURCES & METHODS USED

NPIC/D-76/70

10 MAR 1970

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Several groups of analysts from the National Photographic Interpretation Center recently visited your installation to inspect certain special electronics equipment.

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I would like to take this opportunity to express my personal gratitude to you and your staff for the fine cooperation received at the Gaithersburg, Maryland facility. In particular, Mr. M. [redacted] were especially helpful in making the visits both constructive and informative. These trips will contribute significantly to the effectiveness of our analysts dealing with such electronics equipment.

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In accordance with arrangements made between [redacted] of this organization, I am enclosing 27 photographs of this special equipment for [redacted] use.

Sincerely,

Declass Review by
NIMA/DOD

Captain, USN
Acting Director
National Photographic Interpretation Center

Attachments:
27 photographs

SENSITIVE SOURCES & METHODS USED

NOTE: Upon removal of attachment
this memo will become CONFIDENTIAL

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